Search Notes

Appl	icatio	n/Con	trol	No.

10/511,365

Examiner

Hieu P. Nguyen

Applicant(s)/Patent under Reexamination

TEN DOLLE ET AL.

Art Unit

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SEARCHED				
Class	Subclass	Date	Examiner	
330	252	1/4/2006	HN	
330	301	1/8/2006	HN	
330	311	1/8/2006	HN	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1		-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
MOTTOLA STEVEN J	1/4/2006	HN	
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